

Notice of References Cited	Application/Control No. 09/475,135	Applicant(s)/Patent Under Reexamination KWEON ET AL.	
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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
X	A	US-2004/0261108	12-2004	Yuen et al.	725/058
X	B	US-6,807,677	10-2004	Lee, Jae Kyung	725/58
X	C	US-6,798,420	09-2004	Xie, Xiaodong	345/554
X	D	US-6,792,197	09-2004	Helmstetter, Gary	386/83
X	E	US-6,411,337	06-2002	Cove et al.	348/563
X	F	US-5,990,940	11-1999	Hashimoto et al.	348/184
X	G	US-6,179,487	01-2001	Bardon et al.	715/841
X	H	US-6,128,009	10-2000	Ohkura et al.	725/46
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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	X	

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